

**Selection Guide**

		7C281A-25	7C281A-30	Unit
Maximum Access Time		25	30	ns
Maximum Operating Current	Commercial	100	100	mA

**Maximum Ratings<sup>[1]</sup>**

(Above which the useful life may be impaired. For user guidelines, not tested.)

Storage Temperature ..... -65°C to +150°C

Ambient Temperature with Power Applied..... -55°C to +125°C

Supply Voltage to Ground Potential (Pin 24 to Pin 12)..... -0.5V to +7.0V

DC Voltage Applied to Outputs in High Z State ..... -0.5V to +7.0V

DC Input Voltage ..... -3.0V to +7.0V

DC Program Voltage (Pins 18, 20) ..... 13.0V

Static Discharge Voltage..... >2001V (per MIL-STD-883, Method 3015)

Latch-Up Current..... >200 mA

**Operating Range**

Range	Ambient Temperature	V <sub>CC</sub>
Commercial	0°C to +70°C	5V ±10%

**Electrical Characteristics Over the Operating Range<sup>[2,3]</sup>**

Parameter	Description	Test Conditions	7C281A-25		7C281A-30		Unit
			Min.	Max.	Min.	Max.	
V <sub>OH</sub>	Output HIGH Voltage	V <sub>CC</sub> = Min., I <sub>OH</sub> = -4.0 mA	2.4		2.4		V
V <sub>OL</sub>	Output LOW Voltage	V <sub>CC</sub> = Min., I <sub>OL</sub> = 16.0 mA		0.4		0.4	V
V <sub>IH</sub>	Input HIGH Level	Guaranteed Input Logical HIGH Voltage for All Inputs	2.0		2.0		V
V <sub>IL</sub>	Input LOW Level	Guaranteed Input Logical LOW Voltage for All Inputs		0.8		0.8	V
I <sub>IX</sub>	Input Current	GND ≤ V <sub>IN</sub> ≤ V <sub>CC</sub>	-10	+10	-10	+10	μA
I <sub>OZ</sub>	Output Leakage Current	GND ≤ V <sub>OUT</sub> ≤ V <sub>CC</sub> , Output Disabled	-10	+10	-10	+10	μA
I <sub>OS</sub>	Output Short Circuit Current <sup>[4]</sup>	V <sub>CC</sub> = Max., V <sub>OUT</sub> = GND	-20	-90	-20	-90	mA
I <sub>CC</sub>	Power Supply Current	V <sub>CC</sub> = Max., I <sub>OUT</sub> = 0 mA		100		100	mA
V <sub>PP</sub>	Program Voltage		12	13	12	13	V
V <sub>IHP</sub>	Program HIGH Voltage		3.0		3.0		V
V <sub>ILP</sub>	Program LOW Voltage			0.4		0.4	V
I <sub>PP</sub>	Program Supply Current			50		50	mA

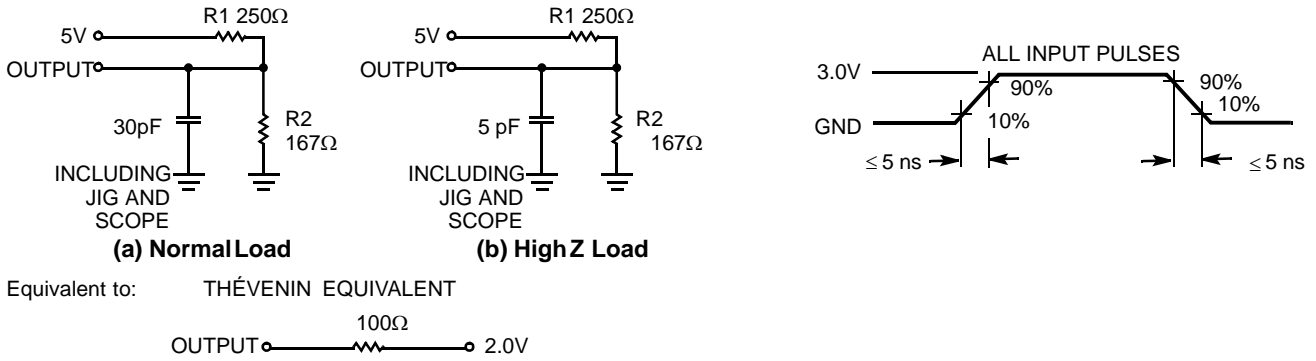
**Capacitance<sup>[3]</sup>**

Parameter	Description	Test Conditions	Max.	Unit
C <sub>IN</sub>	Input Capacitance	T <sub>A</sub> = 25°C, f = 1 MHz, V <sub>CC</sub> = 5.0V	10	pF
C <sub>OUT</sub>	Output Capacitance		10	pF

**Notes**

1. The voltage on any input or I/O pin cannot exceed the power pin during power-up.
2. See the last page of this specification for Group A subgroup testing information.
3. See "Introduction to CMOS PROMs" in this Data Book for general information on testing.
4. For test purposes, not more than one output at a time should be shorted. Short circuit test duration should not exceed 30 seconds.

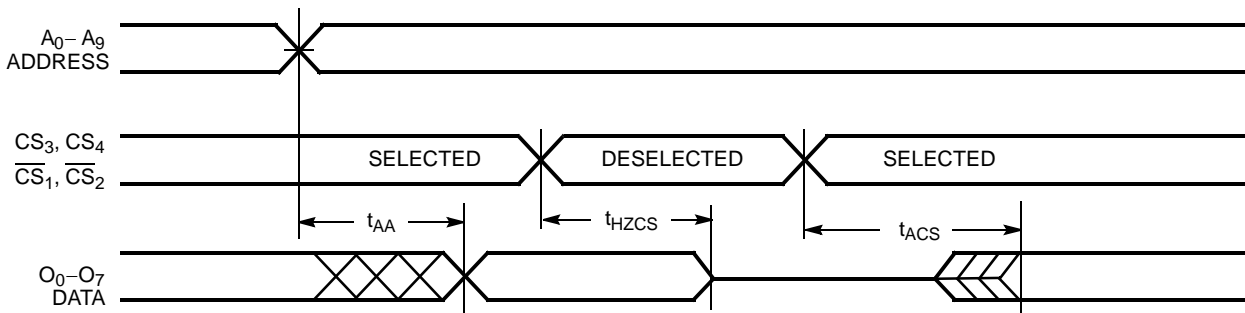
**AC Test Loads and Waveforms<sup>[3]</sup>**



**Switching Characteristics Over the Operating Range<sup>[1,3]</sup>**

Parameter	Description	7C281A-25		7C281A-30		Unit
		Min.	Max.	Min.	Max.	
t <sub>AA</sub>	Address to Output Valid		25		30	ns
t <sub>HZCS</sub>	Chip Select Inactive to High Z		15		20	ns
t <sub>ACS</sub>	Chip Select Active to Output Valid		15		20	ns

**Switching Waveforms**



**Programming Information**

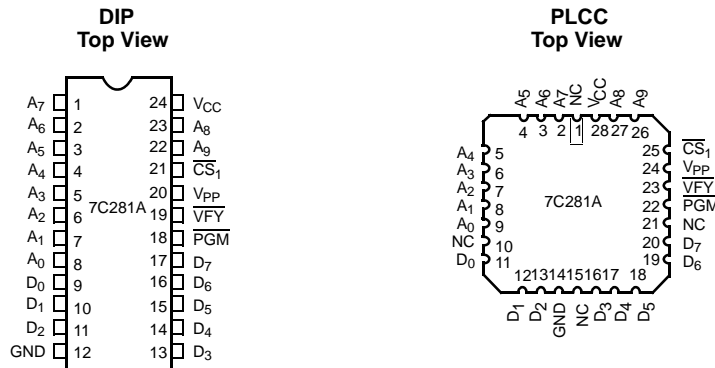
Programming support is available from Cypress as well as from a number of third party software vendors. For detailed

programming information, including a listing of software packages, please see the PROM Programming Information located at the end of this section. Programming algorithms can be obtained from any Cypress representative.

**Table 1. Mode Selection**

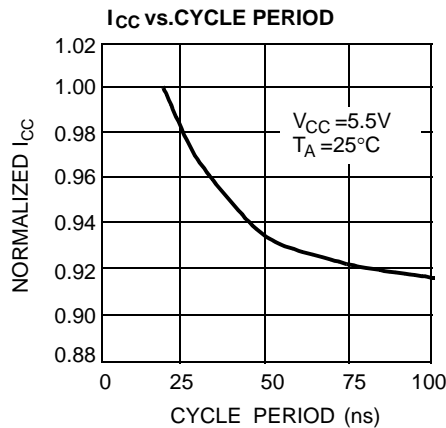
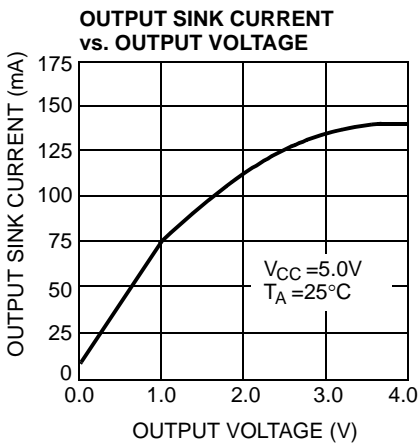
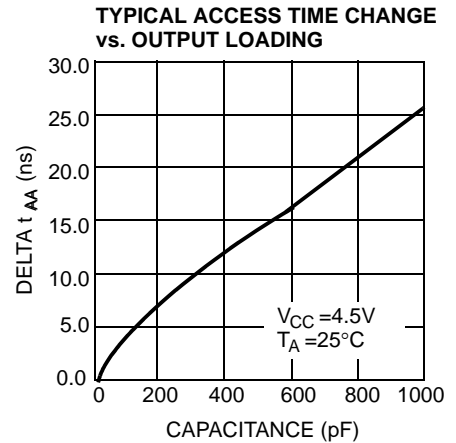
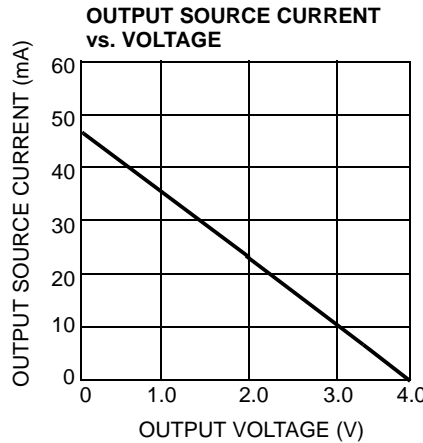
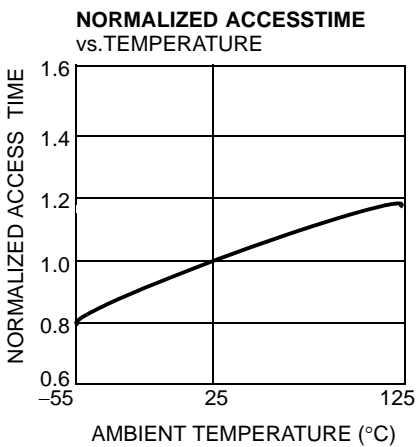
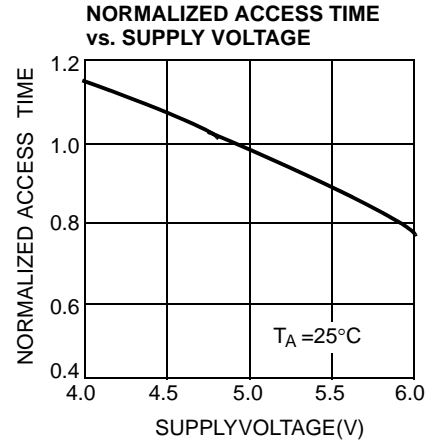
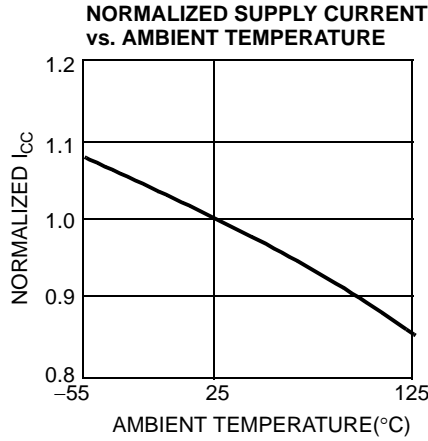
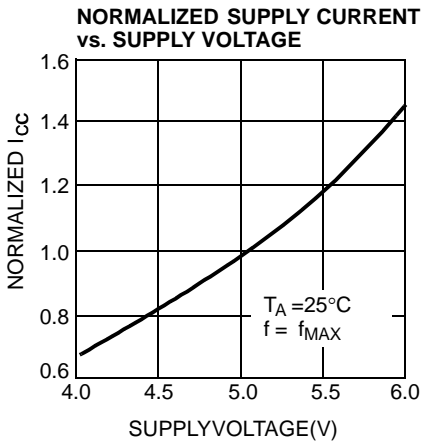
Mode	Pin Function <sup>[5]</sup>						
	Read or Output Disable Other	A <sub>9</sub> -A <sub>0</sub>	CS <sub>4</sub> PGM	CS <sub>3</sub> VFY	CS <sub>2</sub> V <sub>PP</sub>	CS <sub>1</sub> CS <sub>1</sub>	O <sub>7</sub> -O <sub>0</sub> D <sub>7</sub> -D <sub>0</sub>
Read		A <sub>9</sub> -A <sub>0</sub>	V <sub>IH</sub>	V <sub>IH</sub>	V <sub>IL</sub>	V <sub>IL</sub>	O <sub>7</sub> -O <sub>0</sub>
Output Disable		A <sub>9</sub> -A <sub>0</sub>	X	X	V <sub>IH</sub>	X	High Z
Output Disable		A <sub>9</sub> -A <sub>0</sub>	X	V <sub>IL</sub>	X	X	High Z
Output Disable		A <sub>9</sub> -A <sub>0</sub>	V <sub>IL</sub>	X	X	X	High Z
Output Disable		A <sub>9</sub> -A <sub>0</sub>	X	X	X	V <sub>IH</sub>	High Z
Program		A <sub>9</sub> -A <sub>0</sub>	V <sub>ILP</sub>	V <sub>IHP</sub>	V <sub>PP</sub>	V <sub>ILP</sub>	D <sub>7</sub> -D <sub>0</sub>
Program Verify		A <sub>9</sub> -A <sub>0</sub>	V <sub>IHP</sub>	V <sub>ILP</sub>	V <sub>PP</sub>	V <sub>ILP</sub>	O <sub>7</sub> -O <sub>0</sub>
Program Inhibit		A <sub>9</sub> -A <sub>0</sub>	V <sub>IHP</sub>	V <sub>IHP</sub>	V <sub>PP</sub>	V <sub>ILP</sub>	High Z
Intelligent Program		A <sub>9</sub> -A <sub>0</sub>	V <sub>ILP</sub>	V <sub>IHP</sub>	V <sub>PP</sub>	V <sub>ILP</sub>	D <sub>7</sub> -D <sub>0</sub>
Blank Check		A <sub>9</sub> -A <sub>0</sub>	V <sub>IHP</sub>	V <sub>ILP</sub>	V <sub>PP</sub>	V <sub>ILP</sub>	Zeros

**Figure 1. Programming Pinouts**



**Note**  
5. X = "don't care" but not to exceed V<sub>CC</sub> ±5%.

Typical DC and AC Characteristics

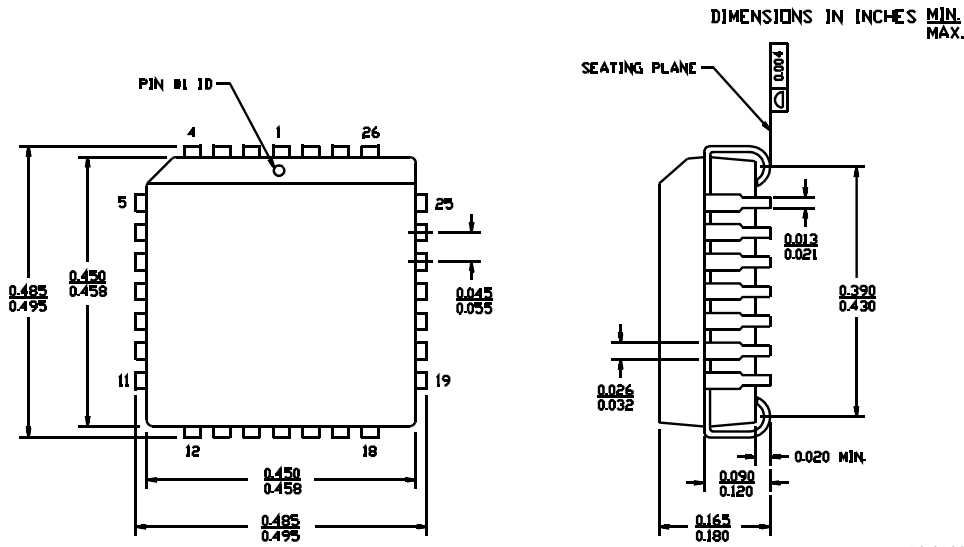


Ordering Information

Speed (ns)	Ordering Code	Package Name	Package Type	Operating Range
25	CY7C281A-25JC	J64	28-Lead Plastic Leaded Chip Carrier	Commercial
30	CY7C281A-30PC	P13	24-Lead (300-Mil) Molded DIP	Commercial

Package Diagrams

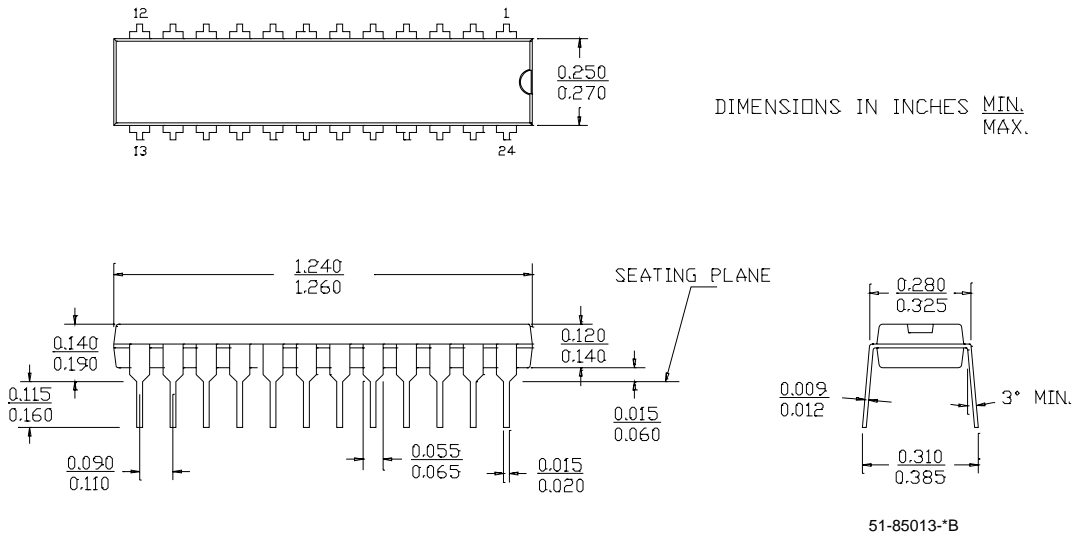
Figure 2. 28-Lead Plastic Leaded Chip Carrier J64



51-85001-\*A

Package Diagrams

Figure 3. 24-Lead (300-Mil) PDIP P13



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**Document History Page**

<b>Document Title: CY7C281A 1K x 8 PROM</b>				
<b>Document Number: 38-04003</b>				
<b>REV.</b>	<b>ECN NO.</b>	<b>Issue Date</b>	<b>Orig. of Change</b>	<b>Description of Change</b>
**	113859	03/06/02	DSG	Changed from Spec number: 38-00227 to 38-04003
*A	118902	10/09/02	GBI	Updated ordering information
*B	122244	12/27/02	RBI	Added power up requirements to Maximum ratings information
*C	499538	See ECN	PCI	Updated ordering information